Supporting Information

Durable Hydrogen Evolution from Water Driven by Sunlight using (Ag, Cu)GaSe$_2$ Photocathodes Modified with CdS and CuGa$_3$Se$_5$

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Preparation of Mo/Ti/SLG substrates

Mo was deposited onto ultrasonically cleaned soda-lime glass (SLG) substrates as the back contact by radio frequency (RF) magnetron sputtering. Prior to Mo deposition, a thin Ti layer was sputtered as a buffer layer. Sputtering was carried out using high-purity Ti (99.98%) and Mo (99.9%) targets under an Ar atmosphere (8.0×10⁻² Pa) at an RF power of 100 W. The SLG substrates were kept at ca. 500°C throughout the deposition process, and the deposition times for Ti and Mo were 5 and 20 min, respectively.

Surface modification with CdS

CdS layers were formed on the surface of CuGa₃Se₅/ACGSe films by the chemical bath deposition (CBD) method.¹ Prior to CdS deposition, the surface of the CuGa₃Se₅/ACGSe films was pretreated with Cd²⁺ by dipping the samples into an aqueous solution containing 2 M NH₄OH (Wako, 28 wt%) and 7.5 mM Cd(CH₃COO)₂ (Kanto, 98%) at 80°C for 10 min. CBD of CdS was performed by immersing the Cd²⁺-pretreated specimens in a bath solution containing 0.375 M SC(NH₂)₂ (Kanto, 98%), 7.5 mM Cd(CH₃COO)₂, and 2 M NH₄OH at 65°C for 6 min, resulting in the deposition of a CdS layer with a thickness of ca. 80 nm. After CdS deposition, the samples were annealed in air at 300°C for 60 min.
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**Surface modification with Pt**

The prepared CdS/CuGa₃Se₅/ACGSe thin film samples were fabricated into electrodes by connecting a lead wire to the Mo backside layer and covering the unnecessary parts with epoxy resin. The electrodes prepared were then surface-modified with Pt as a hydrogen evolution catalyst by PEC deposition using a 3-electrode setup. PEC deposition of Pt was conducted using a solution containing 10 μM H₂PtCl₆ (Kanto, 98.5%) and 0.1 M Na₂SO₄ (Wako, 99%) at an applied potential of ca. −0.5 to −0.6 Vₐg/AgCl under illumination by 420–800 nm light from a 300 W Xe lamp equipped with filters. PEC deposition was continued until the photocurrent saturated. Schematic of photoelectrode fabrication process for the Pt- and CdS-modified CuGa₃Se₅/ACGSe thin film electrodes (Pt/CdS/CuGa₃Se₅/ACGSe) is illustrated in scheme 1.

**Scheme 1** Schematic of fabrication process for Pt/CdS/CuGa₃Se₅/ACGSe electrodes on Mo/Ti/SLG substrates.
Characterization of ACGSe/CuGaSeS thin films

Structural properties were characterized using X-ray diffraction (XRD; RINT-Ultima III, Rigaku), scanning electron microscopy (SEM; S-4700, Hitachi), and scanning transmission electron microscopy (STEM; JEM-2800, JEOL and EM-002BF-Twin EDS system, JEOL). The crystal structures of the samples were determined using XRD, while the film microstructure was characterized by SEM and TEM. Top and cross-sectional surfaces were studied by SEM. TEM measurements were performed to characterize the cross-sectional structure of the films. The ionization potentials and band gaps of the samples were analyzed by photoelectron spectroscopy in air (PESA; AC-3, Riken Keiki), and UV-vis transmittance spectroscopy (V-670DS, Jasco), respectively.

Gas product analysis

The analysis of gas production was conducted using an airtight 3-electrode cell connected to a gas chromatograph (Agilent 3000 Micro GC, Agilent Technologies). The measurements were performed under an Ar-saturated atmosphere using a 0.1 M aqueous Na$_2$HPO$_4$ solution as the electrolyte with the pH adjusted to 10 by NaOH addition. The 420–800 nm light from a 150 W Xe lamp equipped with a cutoff filter (HOYA, L42) and a cold mirror (Optline, CM-1) was employed as light source. The amounts of evolved oxygen and hydrogen were measured by gas chromatography.
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Spectrum of the used solar simulator

**Fig. S1** Spectrum of the used solar simulator in PEC measurements. The spectrum of solar simulator was calibrated to AM 1.5G (ASTM G173-03).
Current-potential ($I$–$E$) curves for Pt/CdS/ACGSe and Pt/CdS/CuGa$_3$S$_5$/ACGSe electrodes

Fig. S2 $I$–$E$ curves for Pt/CdS/ACGSe (a), and Pt/CdS/CuGa$_3$S$_5$/ACGSe with CuGa$_3$S$_5$ deposited for 15 min (b). A 0.1 M aqueous Na$_2$HPO$_4$ solution (adjusted to pH 10 by addition of NaOH) was employed as the electrolyte. An applied potential was swept in the positive direction at 5 mV s$^{-1}$ under intermittent irradiation with simulated sunlight. The reported Pt/CdS/ACGSe is shown as a reference, that sample was measured in 0.1 M Na$_2$SO$_4$ (adjusted to pH 9.5 by addition of NaOH) under simulated sunlight irradiation.$^2$
Half-cell solar-to-hydrogen efficiency (HC-STH) for Pt/CdS/CuGa$_3$S$_5$/ACGSe electrode

**Fig. S3** HC-STH values for the Pt/CdS/ACGSe and Pt/CdS/CuGa$_3$S$_5$/ACGSe calculated from the $I$–$E$ curves under the simulated sunlight shown in Fig. 1(c).
Calculated photocurrent for Pt/CdS/CuGa₃Se₅/ACGSe electrode

**Fig. S4** Calculated photocurrent for Pt/CdS/CuGa₃Se₅/ACGSe with CuGa₃Se₅ deposited for 15 min. The calculation was done by integrating the measured IPCE for Pt/CdS/CuGa₃Se₅/ACGSe over the AM 1.5G spectrum (ASTM G173-03). A photocurrent of 10.2 mA cm⁻² was calculated at a wavelength of 760 nm, which is only slightly larger than the photocurrent of ca. 8.8 mA cm⁻² at 0 V_{RHE} determined from the I–E curves, indicating the accuracy of the measured I–E curves and IPCE spectra. In addition, the discrepancy between the observed photocurrent and the theoretical maximum photocurrent of 24 mA cm⁻² at 760 nm, obtained by assuming 100% IPCE, indicates a high potential for further improvement.
Gas product analysis for Pt/CdS/CuGa$_3$Se$_5$/ACGSe at high applied potential

**Fig. S5** Current-time curve for the Pt/CdS/CuGa$_3$Se$_5$/ACGSe electrode with CuGa$_3$Se$_5$ deposited for 15 min at an applied potential of 0.75 V$_{RHE}$ (a), and the corresponding amount of H$_2$ and O$_2$ that evolved during the measurement (b). An airtight 3-electrode configuration was used, with a Pt wire and an Ag/AgCl electrode as the counter and reference electrodes, respectively. A 0.1 M Na$_2$HPO$_4$ (adjusted to pH 10 by addition of NaOH) and a 150 W Xe lamp (420–800 nm) equipped with a cutoff filter (HOYA, L42) and a cold mirror (Optline, CM-1) were used as the electrolyte and light source, respectively. The dashed lines indicate the expected amounts of hydrogen and oxygen for a Faradaic efficiency of unity.
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Surface morphology of CuGa₃Se₅ reference sample

Fig. S6 Top-view SEM image of CuGa₃Se₅ reference sample deposited for 15 min on Mo/Ti/SLG substrate.
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Band gaps and VBM potentials for ACGSe and CuGa₃Se₅ reference samples

The band gap and VBM potential for the ACGSe and CuGa₃Se₅ reference samples were investigated using UV-vis transmittance and photoelectron spectroscopy in air (PESA), respectively. UV-vis transmittance spectra of ACGSe and CuGa₃Se₅ are shown in Fig. S7. The band gap for ACGSe and CuGa₃Se₅ was estimated to be ca. 1.65 and 1.85 eV (Fig. S8), respectively, using the Tauc method.³

PESA spectra of the ACGSe and CuGa₃Se₅ reference samples are shown in Fig. S9. The VBM potential vs. NHE for CuGa₃Se₅ was ca. 0.25 V higher than that for ACGSe. On the basis of the variations in the band gap and the VBM potential, we concluded that the increase in the band gap for CuGa₃Se₅ was mainly due to deepening of the VBM position.

**Fig. S7** UV-vis transmittance spectra of the ACGSe and CuGa₃Se₅ (15 min) reference samples deposited on FTO substrates.
Fig. S8 Tauc plots for the reference samples of ACGSe (a), and CuGa₃Se₅ (b). The band gap was determined by using the Tauc extrapolation method.³
**Fig. S9** PESA spectra of the ACGSe and CuGa₃Se₅ (15 min) reference samples prepared on Mo/Ti/SLG substrates. The valence band maximum (VBM) potential for CuGa₃Se₅ was ca. 0.25 V higher than that for ACGSe.
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Band alignment at solid–liquid interface

The band alignment at the solid–liquid interface was calculated by solving Poisson’s equation, which for CdS and ACGSe (or CuGa₃Se₅), is respectively given by

\[
\frac{d^2 \varphi}{dx^2} = -\frac{qN_D}{\varepsilon \varepsilon_0} \tag{S1}
\]
\[
\frac{d^2 \varphi}{dx^2} = \frac{qN_A}{\varepsilon \varepsilon_0} \tag{S2}
\]

where \( \varphi, x, q \) and \( \varepsilon_0 \) are the built-in potential, position, electron charge (1.602×10⁻¹⁹ C), and vacuum permittivity (8.85×10⁻¹² F m⁻¹), respectively. The relative dielectric constant (\( \varepsilon \)) of CdS and ACGSe was assumed to be 10.⁴,⁵ The concentration of donors (\( N_D \)) in the CdS layer and acceptors (\( N_A \)) in the ACGSe (or CuGa₃Se₅) layer was set to \( 10^{16} \).⁴,⁵ The band gap for ACGSe, CuGa₃Se₅, and CdS was 1.65 (see Fig. S8(a)),² 1.85 (see Fig. S8(b))⁶ and 2.4 eV,⁷ respectively. The parameters used for the calculation of the band alignments are shown in Table S1.

The difference between the Fermi level (\( E_F \)) and the CBM for CdS, and that between \( E_F \) and the VBM for ACGSe (or CuGa₃Se₅), was assumed to be 0.2 eV.⁴,⁵ The VBM offset at the CdS/ACGSe and CuGa₃Se₅/ACGSe interfaces was 0.98⁸ and 0.3 eV (see Fig. S9),⁹ respectively. Based on these values and the transitivity rule,¹⁰ the VBM offset at the CdS/CuGa₃Se₅ interface was determined to be 0.68 eV. The flat-band potential for CdS was set to \(-0.04 \) Vₚₐₜ for pH 10 derived from \(-0.1 \) Vₚₐₜ (pH 9).⁴,⁵,¹¹

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Table S1 Semiconductors parameters used to calculate the band alignments.

<table>
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<th>Parameters</th>
<th>CdS</th>
<th>CuGaSeS</th>
<th>ACGSe</th>
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<td>Thickness $t$ (nm)</td>
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<td>100</td>
<td>&gt;1000</td>
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<td>Donor density $N_D$ (cm$^{-3}$)</td>
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<td>–</td>
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<td>Acceptor density $N_A$ (cm$^{-3}$)</td>
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<td>$1.0 \times 10^{16}$</td>
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<td>Band gap $E_g$ (eV)</td>
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<td>1.65</td>
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<td>Relative dielectric constant $\varepsilon$</td>
<td>10</td>
<td>10</td>
<td>10</td>
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8. T. Schulmeyer, R. Kniese, R. Hunger, W. Jaegermann, M. Powalla and A. Klein,
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